

<b>Notice of References Cited</b>	Application/Control No. 10/075,283	Applicant(s)/Patent Under Reexamination IWAYAMA ET AL.	
	Examiner Neveen Abel-Jalil	Art Unit 2165	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,859,972	01-1999	Subramaniam et al.	709/203
*	B	US-6,163,782	12-2000	Singhal, Amitabh Kumar	707/104.1
*	C	US-6,263,342	07-2001	Chang et al.	707/103R
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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